Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/623,155	WANG ET AL.	
Examiner	Art Unit	
Shin-Lin Chen	1632	

SEARCHED						
Class	Subclass	Date	Examiner			
536	23.1					
536	23.5					
435	320.1					
435	455		,			
424	93.2					
424	184.1	3/28/2007	4n			

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
424	184.1			
536	23.5			
435	320.1			
435/455, 424/93.2, Sequence Interference Search (10-18-06)		3/28/2007	4n	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Updated, parents reviewed and updated.	3/28/2007	4u		
		·		